

INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
53674-015

SERIAL NO.  
09/462876

APPLICANT  
Hitoshi SUMIYA, et al.

FILING DATE  
January 18, 2000

GROUP  
1255

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>a</i>	10-158065	6/16/98	Japan				
<i>u</i>	3-37161	2/18/91	Japan				
<i>a</i>	61-117107	6/4/86	Japan				
<i>a</i>	9-59068	3/4/97	Japan				
<i>a</i>	55-167110	12/26/80	Japan				

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER *[Signature]* DATE CONSIDERED *1/10/2001*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

SERIAL NO.  
09/462.876

APPLICANT  
**Hitoshi SUMIYA, et al.**

FILING DATE  
**January 18, 2000**

**GROUP  
1755**

(PTO-1449)

## U.S. PATENT DOCUMENTS

[illegible]

# FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>n</i>	63-394	01/06/88	JAPAN	11111111			
<i>m</i>	3-159964	07/09/91	JAPAN				
<i>a</i>	8-141822	06/04/96	JAPAN				
<i>h</i>	8-47801	02/20/96	JAPAN				
<i>g</i>	49-27518	07/18/74	JAPAN				
<i>h</i>	47-34099	11/20/72	JAPAN				

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

**EXAMINER**

DATE CONSIDERED

**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.